## **HAT2054M**

# Silicon N Channel Power MOS FET Power Switching

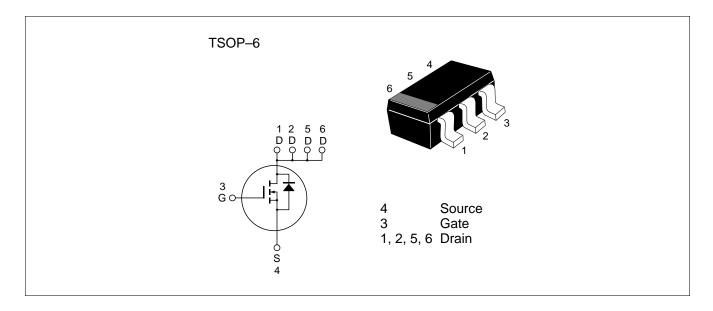
# **HITACHI**

ADE-208-756B(Z) Preliminary 3rd. Edition December 1998

#### **Features**

- Low on-resistance
- Low drive current
- High density mounting
- 4.5V gate drive device can be driven from 5V source

#### **Outline**





### **HAT2054M**

#### **Absolute Maximum Ratings** (Ta = 25°C)

| Item                                   | Symbol                         | Ratings     | Unit |  |
|--|--------------------------------|-------------|------|--|
| Drain to source voltage                | V <sub>DSS</sub>               | 30          | V    |  |
| Gate to source voltage                 | V <sub>GSS</sub>               | ±20         | V    |  |
| Drain current                          | <sub>D</sub> *2                | 6.3         | A    |  |
| Drain peak current                     | l *1<br>D(pulse)               | 25.2        | A    |  |
| Body-drain diode reverse drain current | <sub>DR</sub> *2               | 6.3         | A    |  |
| Channel dissipation                    | Pch <sub>(pulse)</sub> *2      | 2.0         | W    |  |
|  | Pch <sub>(continuous)</sub> *3 | 1.05        | W    |  |
| Channel temperature                    | Tch                            | 150         | °C   |  |
| Storage temperature                    | Tstg                           | -55 to +150 | °C   |  |

Notes: 1. PW  $\leq$  10 $\mu$ s, duty cycle  $\leq$  1 %

2. When using the alumina ceramic board (50 x 50 x 0.7 mm), PW≤ 5s,Ta=25°C

3. When using the alumina ceramic board (50 x 50 x 0.7 mm) , $Ta=25^{\circ}C$ 

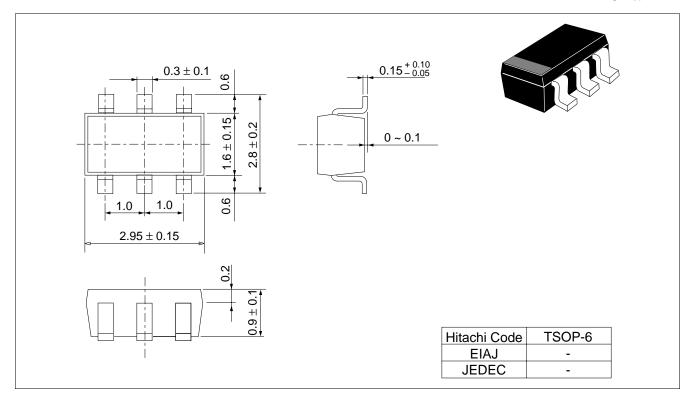
#### **Electrical Characteristics** ( $Ta = 25^{\circ}C$ )

| Symbol                          | Min  | Тур   | Max   | Unit  | Test Conditions                                       |
|---------------------------------|--|---|---|---|---|
| $V_{(BR)DSS}$                   | 30   | _   | _   | V   | $I_{D} = 10 \text{mA}, V_{GS} = 0$                    |
| I <sub>GSS</sub>                | _  | _   | ±0.1  | μΑ  | $V_{GS} = \pm 20V, V_{DS} = 0$                        |
| I <sub>DSS</sub>                | _  | _   | 1   | μΑ  | $V_{DS} = 30 \text{ V}, V_{GS} = 0$                   |
| $V_{\text{GS(off)}}$            | 1.0  | _   | 2.5   | V   | $V_{DS} = 10V$ , $I_D = 1mA$                          |
| $R_{\scriptscriptstyle DS(on)}$ | _  | 26  | 31  | $m\Omega$   | $I_D = 3A, V_{GS} = 10V^{*1}$                         |
|                                 | _  | 40  | 52  | mΩ  | $I_D = 3A, V_{GS} = 4.5V^{*1}$                        |
| y <sub>fs</sub>                 | 4  | 7   | _   | S   | $I_D = 3A, V_{DS} = 10V^{*1}$                         |
| Ciss                            | _  | 620   | _   | pF  | V <sub>DS</sub> = 10V                                 |
| Coss                            | _  | 170   | _   | pF  | $V_{GS} = 0$  |
| Crss                            | _  | 110   | _   | pF  | f = 1MHz  |
| $t_{d(on)}$                     | _  | 13  | _   | ns  | $V_{GS} = 10V$ , $I_D = 3A$                           |
| t <sub>r</sub>                  | _  | 90  | _   | ns  | $R_L = 3.3\Omega$                                     |
| $t_{\text{d(off)}}$             | _  | 50  | _   | ns  |   |
| t <sub>f</sub>                  | _  | 40  | _   | ns  |   |
| $V_{DF}$                        | _  | 0.95  | _   | V   | $IF = 6.3A$ , $V_{GS} = 0^{*1}$                       |
| t <sub>rr</sub>                 | _  | (50)  | _   | ns  | IF = 6.3A, $V_{GS} = 0$<br>diF/ dt =20A/ $\mu$ s      |
|                                 | $\begin{array}{c} V_{(BR)DSS} \\ I_{GSS} \\ I_{DSS} \\ \end{array}$ $\begin{array}{c} V_{GS(off)} \\ R_{DS(on)} \\ \end{array}$ $\begin{array}{c} R_{DS(on)} \\ \end{array}$ $\begin{array}{c} V_{fs} I \\ \end{array}$ $\begin{array}{c} Ciss \\ Coss \\ Crss \\ t_{d(on)} \\ t_{r} \\ t_{d(off)} \\ \end{array}$ $\begin{array}{c} t_{r} \\ t_{d(off)} \\ \end{array}$ | $\begin{array}{c cccc} V_{(BR)DSS} & 30 \\ \hline I_{GSS} & - \\ \hline I_{DSS} & - \\ \hline V_{GS(off)} & 1.0 \\ \hline R_{DS(on)} & - \\ \hline I_{DSS} & - \\ \hline R_{DS(on)} & - \\ \hline I_{DS} & - \\ I_{DS} & - \\ \hline I_$ | $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ |

Note: 1. Pulse test

### **Package Dimensions**

Unit: mm



#### **Cautions**

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## HITACHI

Hitachi, Ltd.

Semiconductor & Integrated Circuits.

Nippon Bldg., 2-6-2, Ohte-machi, Chiyoda-ku, Tokyo 100-0004, Japan Tel: Tokyo (03) 3270-2111 Fax: (03) 3270-5109

**URL** NorthAmerica http:semiconductor.hitachi.com/ Europe

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#### For further information write to:

Hitachi Semiconductor (America) Inc. 179 East Tasman Drive, San Jose,CA 95134 Tel: <1> (408) 433-1990 Fax: <1>(408) 433-0223 Hitachi Europe GmbH Electronic components Group Dornacher Stra§e 3 D-85622 Feldkirchen, Munich Germany

Tel: <49> (89) 9 9180-0 Fax: <49> (89) 9 29 30 00

Hitachi Europe Ltd. Electronic Components Group Whitebrook Park Lower Cookham Road Maidenhead

Berkshire SL6 8YA, United Kingdom Tel: <44> (1628) 585000 Fax: <44> (1628) 778322

Hitachi Asia Pte. Ltd. 16 Collyer Quay #20-00 Hitachi Tower Singapore 049318 Tel: 535-2100

Fax: 535-1533 Hitachi Asia Ltd.

Taipei Branch Office 3F, Hung Kuo Building. No.167, Tun-Hwa North Road, Taipei (105) Tel: <886> (2) 2718-3666 Fax: <886> (2) 2718-8180

Hitachi Asia (Hong Kong) Ltd. Group III (Electronic Components) 7/F., North Tower, World Finance Centre, Harbour City, Canton Road, Tsim Sha Tsui, Kowloon, Hong Kong Tel: <852> (2) 735 9218 Fax: <852> (2) 730 0281

Telex: 40815 HITEC HX

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